

Search Notes

Application/Control No.

10/707,285

Examiner

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Applicant(s)/Patent under
Reexamination

SLACK, KEITH E.

Art Unit

3635

SEARCHED

Class	Subclass	Date	Examiner
52	749.1	9/28/2006	CN
52	749.12		
52	741.1		
52	746.11		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS search	9/28/2006	CN
inventor name search	9/28/2006	CN
interference search with PG-Pub	9/28/2006	CN
search related art	9/28/2006	CN